

<b>Notice of References Cited</b>	Application/Control No. 10/586,200		Applicant(s)/Patent Under Reexamination TOLLNER, MARTIN ERNST	
	Examiner AMENE S. BAYOU		Art Unit 3746	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,474,949	11-2002	Arai et al.	417/2
*	B	US-7,077,159	07-2006	Reimer et al.	137/565.23
*	C	US-6,200,107	03-2001	Brewster, Barrie Dudley	417/251
*	D	US-5,746,581	05-1998	Okumura et al.	417/2
*	E	US-6,966,967	11-2005	Curry et al.	156/345.26
*	F	US-6,419,455	07-2002	Rousseau et al.	417/36
*	G	US-5,150,734	09-1992	Chiba, Takahiro	137/565.33
*	H	US-7,472,581	01-2009	Kitazawa et al.	73/49.2
*	I	US-2002/0098708	07-2002	Kumihashi et al.	438/714
*	J	US-6,142,163	11-2000	McMillin et al.	137/14
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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